A new crystal bender for the ID31 Laue-Laue monochromator

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□ Introduction: The ID31 Beamline

□ Specification of the bender

Principle and design

Analysis: Analytical
 FEA - mechanical model
 FEA - non linear thermo-mechanical model

Prototype

□ Commissioning (optical and X-ray)

Conclusion



Preliminary questions

What will be the behavior of the crystal when I will put the white beam?
Which parasitic stresses will be inside the crystal, when I will bend it?
What is the parallelism between my surface and my crystalline planes?
What will happen when I will clamp my crystal?



INTRODUCTION: THE ID31 BEAMLINE

Experimental techniques: tomography / reflectivity / SAXS / WAXS Samples: fuel cells, solar cells, rechargeable batteries, catalytic materials...



Laue-Laue monochromator At 105m from the source 1- What will be the behavior of the crystal when I will put the white beam?

The ID31 beamline:

X-Ray energies ranging from 20 to 150keV. The energy range 50-150 keV is covered by a Laue-Laue monochromator located at 105 meters from the source.

Absorbers

T_{si}=125K

0 = 3

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The monochromator in short and bender specification





BENDER DESIGN





ANALYTICAL APPROACH

Hypothesis

- Mechanical beam theory approximation formula (1)
- The weight is negligible because the crystal is vertical.
- The forces F [N] applied by the two jacks are equal.
- The anticlastic effect is not considered here
- (x,y) origin is taken at the middle of the crystal



	With : E Young modulus of Si [N/m ²]
$d^2u M(x)$	I the inertia of the beam = $constant=bh^3/12 [m^4]$
$\frac{1}{dr^2} = \frac{1}{EI}$	b: width of the crystal, h: thickness
	<i>M(x):</i> local bending moment [N.m]

Deflection $u_1(x)$ of the crystal between the fixing points A and B and $u_2(x)$ beyond A,B

$$u_1(x) = \frac{d.F}{EI} x^2$$
 $u_2(x) = \frac{2d.Fa^2}{EI} x - \frac{dFa^2}{EI}$ (2)



Example of deflection calculation on half of the crystal using Matlab.

For a given expected radius, the program gives the displacement to be requested to the jacks. Reference of all the values are position "flat" of the crystal.





Maximum stress in the flexure: 110MPa (Invar limit: 450MPa) Pushing force for one jack: 140N (jackMax:240N)







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Radius of curvature: 19.5m

Analytical displacement to be requested to the jack [m]= 291e-06 Solidworks simulation displacement in D[m]: 294.8e-6

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CRYO BEHAVIOR: PHYSICAL PROPERTIES FOR INVAR (FE-36NI) AND SILICON

Thermal conductivity (log scale)



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Expansion coefficient ∆L/L



Non linear thermo-mechanical FEA modelisation and first X-Ray commissioning

The maximum stress between clamp and crystal is \sim 100MPa \rightarrow solution: we put indium at the interface to absorb the mechanical stresses.



Video of deformation when cooling down



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PROTOTYPE AND TEST BENCHES





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DIFFICULTIES

Capacitive sensors

The noise of the capacitive sensors remains a little high. Their behavior at very low temperature is not fully tested yet.

Piezo-jacks control

The control of the piezo-jack is not straight-forward due to the fact that only one sensor (the capacitive one) reads the displacement of both the piezo and the stepper motor.





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CONCLUSION

Despite of all the difficulties, the systems works well.

The stability in time is very good.

Analytical model/FEA model/ optical tests and first X-ray commissioning gives very similar results in the behavior of the system.

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